

Notice of References Cited	Application/Control No. 10/731,479	Applicant(s)/Patent Under Reexamination INOUE, TOMOHIRO	
	Examiner Tony Chuo	Art Unit 1745	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0019792	09-2001	Wozniczka et al.	429/38
	B	US-			
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FOREIGN PATENT DOCUMENTS

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